

# 1MBI400U-120



## IGBT Module U-Series 1200V / 400A 1 in one-package

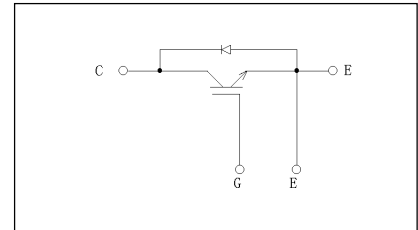
### ■ Features

- High speed switching
- Voltage drive
- Low inductance module structure

### ■ Applications

- Inverter for Motor drive
- AC and DC Servo drive amplifier
- Uninterruptible power supply
- Industrial machines, such as Welding mac

### ■ Equivalent Circuit Schematic



### ■ Maximum ratings and characteristics

#### ● Absolute maximum ratings (at Tc=25°C unless otherwise specified)

Item	Symbol	Conditions	Rating	Unit	
Collector-Emitter voltage	V <sub>CES</sub>		1200	V	
Gate-Emitter voltage	V <sub>GES</sub>		±20	V	
Collector current	I <sub>c</sub>	Continuous	T <sub>c</sub> =25°C	600	A
			T <sub>c</sub> =80°C	400	
	I <sub>cp</sub>	1ms	T <sub>c</sub> =25°C	1200	
			T <sub>c</sub> =80°C	800	
	-I <sub>c</sub>			400	
-I <sub>c</sub> pulse	1ms		800		
Collector Power Dissipation	P <sub>c</sub>	1 device	2155	W	
Junction temperature	T <sub>j</sub>		+150	°C	
Storage temperature	T <sub>stg</sub>		-40 to +125		
Isolation voltage   between terminal and copper base *1	V <sub>iso</sub>	AC:1min.	2500	VAC	
Screw Torque	Mounting *2		3.5	N·m	
	Terminals *2		4.5		
	Terminals *2		1.7		

\*1 : All terminals should be connected together when isolation test will be done.

\*2 : Recommendable value : Mounting 2.5 to 3.5N·m(M5 or M6), Terminal 3.5 to 4.5 N·m(M6), 1.3 to 1.7 N·m(M4)

#### ● Electrical characteristics (at Tj=25°C unless otherwise specified)

Item	Symbols	Conditions	Characteristics			Unit	
			Min.	Typ.	Max.		
Zero gate voltage collector current	I <sub>CES</sub>	V <sub>GE</sub> =0V, V <sub>CES</sub> =1200V	–	–	4.0	mA	
Gate-Emitter leakage current	I <sub>GES</sub>	V <sub>CES</sub> =0V, V <sub>GE</sub> =±20V	–	–	800	nA	
Gate-Emitter threshold voltage	V <sub>GE(th)</sub>	V <sub>CES</sub> =20V, I <sub>c</sub> =400mA	4.5	6.5	8.5	V	
Collector-Emitter saturation voltage	V <sub>CE(sat)</sub> (terminal)	V <sub>GE</sub> =15V, I <sub>c</sub> =400A	T <sub>j</sub> =25°C	–	1.95	2.30	V
			T <sub>j</sub> =125°C	–	2.20	–	
	V <sub>CE(sat)</sub> (chip)		T <sub>j</sub> =25°C	–	1.75	2.10	
			T <sub>j</sub> =125°C	–	2.00	–	
Input capacitance	C <sub>ies</sub>	V <sub>CES</sub> =10V, V <sub>GE</sub> =0V, f=1MHz	–	45	–	nF	
Turn-on time	t <sub>on</sub>	V <sub>CC</sub> =600V	–	0.36	1.20	μs	
	t <sub>r</sub>	I <sub>c</sub> =400A	–	0.21	0.60		
	t <sub>r(i)</sub>	V <sub>GE</sub> =±15V	–	0.03	–		
Turn-off time	t <sub>off</sub>	R <sub>G</sub> =1.5 Ω	–	0.37	1.00	μs	
	t <sub>f</sub>		–	0.07	0.30		
Forward on voltage	V <sub>F</sub> (terminal)	V <sub>GE</sub> =0V I <sub>F</sub> =400A	T <sub>j</sub> =25°C	–	1.80	2.10	V
			T <sub>j</sub> =125°C	–	1.90	–	
	V <sub>F</sub> (chip)		T <sub>j</sub> =25°C	–	1.60	1.90	
			T <sub>j</sub> =125°C	–	1.70	–	
Reverse recovery time	t <sub>rr</sub>	I <sub>F</sub> =400A	–	–	0.35	μs	
Lead resistance, terminal-chip*3	R lead		–	0.40	–	mΩ	

\*3:Biggest internal terminal resistance among arm.

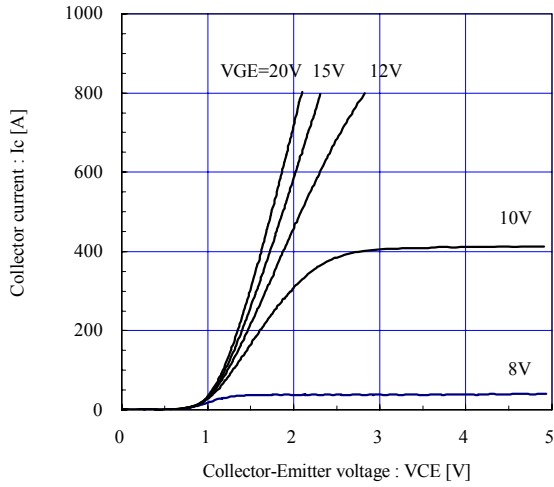
#### ● Thermal resistance characteristics

Items	Symbols	Conditions	Characteristics			Unit
			Min.	Typ.	Max.	
Thermal resistance	R <sub>th(j-c)</sub>	IGBT	–	–	0.058	°C/W
	R <sub>th(j-c)</sub>	FWD	–	–	0.100	°C/W
Contact Thermal resistance	R <sub>th(c-f)</sub> *4	With thermal compound	–	0.0125	–	°C/W

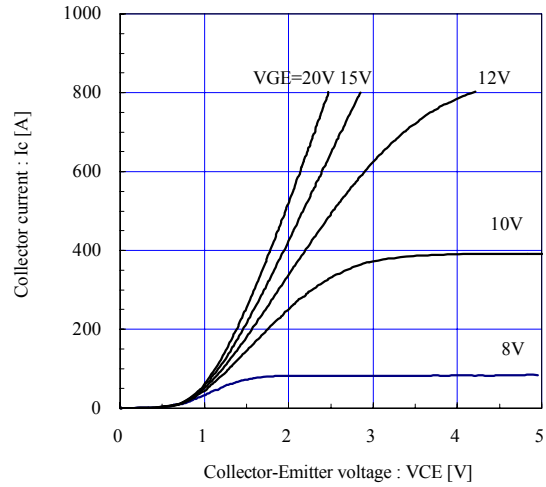
\*4 : This is the value which is defined mounting on the additional cooling fin with thermal compound.

Characteristics (Representative)

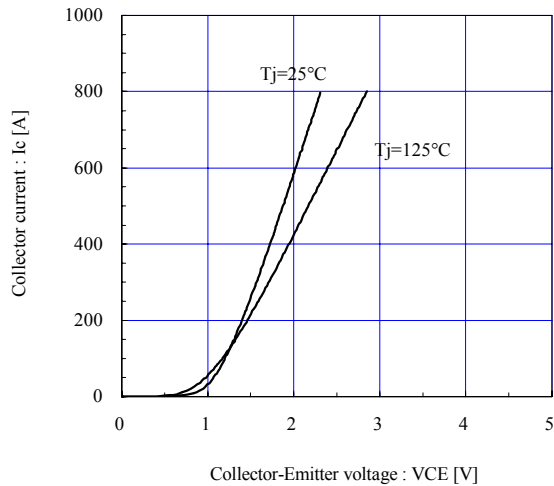
Collector current vs. Collector-Emitter voltage (typ.)  
Tj= 25°C / chip



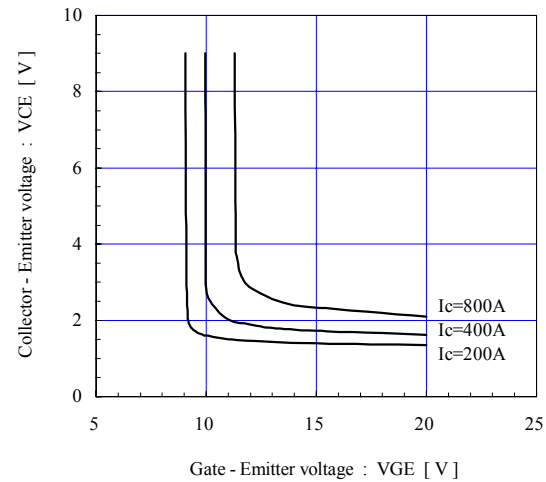
Collector current vs. Collector-Emitter voltage (typ.)  
Tj= 125°C / chip



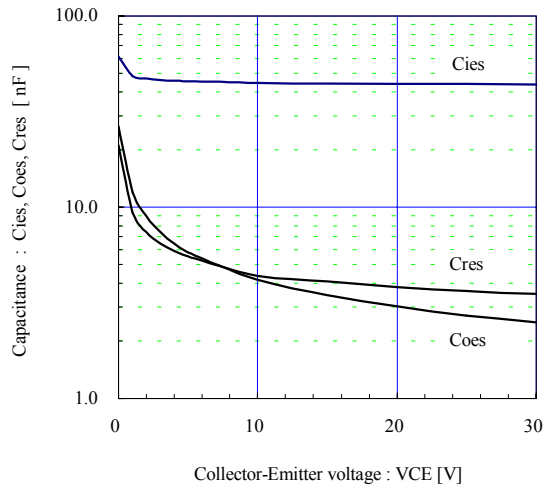
Collector current vs. Collector-Emitter voltage (typ.)  
VGE=15V / chip



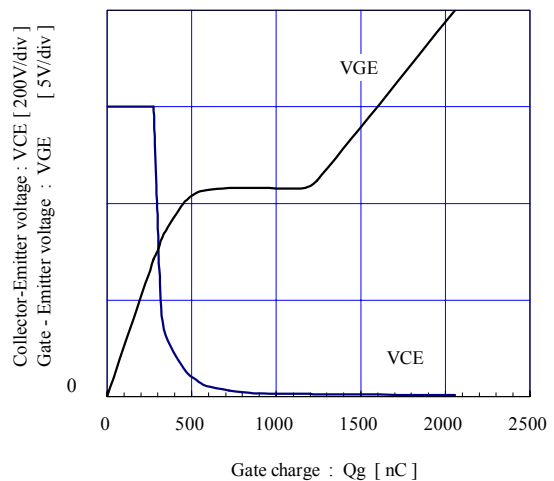
Collector-Emitter voltage vs. Gate-Emitter voltage (typ.)  
Tj=25°C / chip



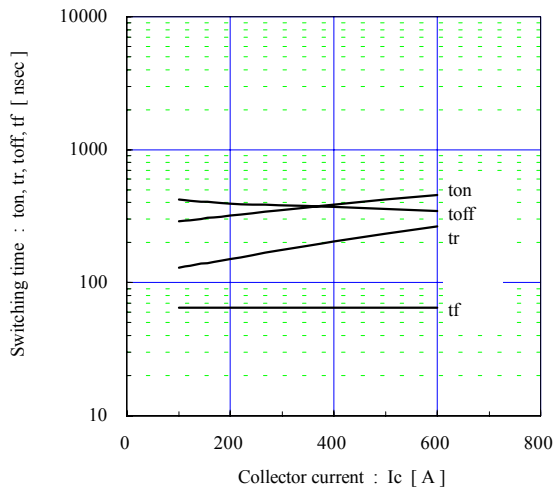
Capacitance vs. Collector-Emitter voltage (typ.)  
VGE=0V, f= 1MHz, Tj= 25°C



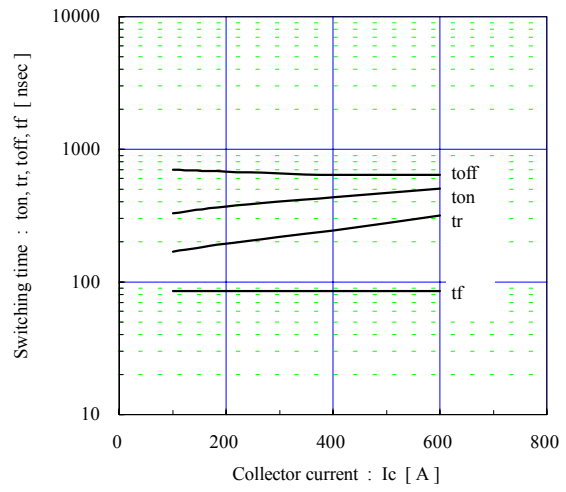
Dynamic Gate charge (typ.)  
Vcc=600V, Ic=400A, Tj= 25°C



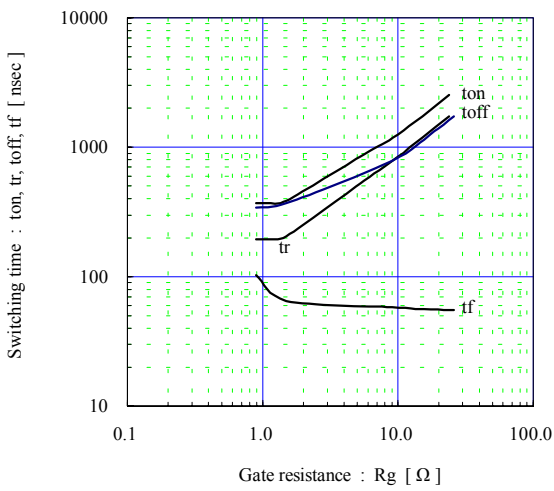
Switching time vs. Collector current (typ.)  
 $V_{cc}=600V, V_{GE}=\pm 15V, R_g=1.5\Omega, T_j=25^\circ C$



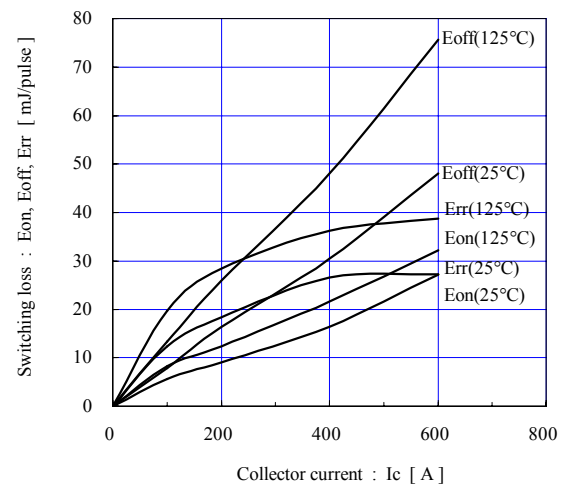
Switching time vs. Collector current (typ.)  
 $V_{cc}=600V, V_{GE}=\pm 15V, R_g=1.5\Omega, T_j=125^\circ C$



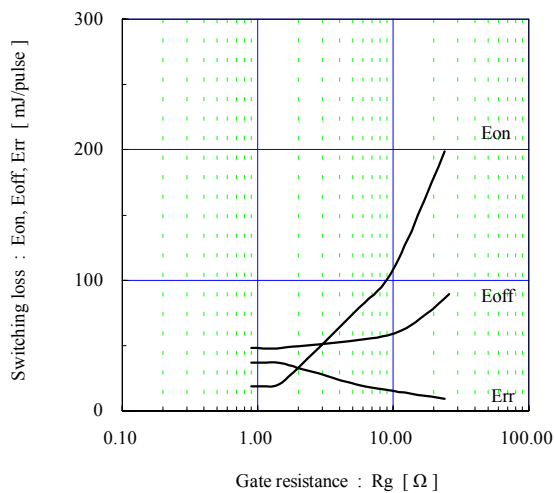
Switching time vs. Gate resistance (typ.)  
 $V_{cc}=600V, I_c=400A, V_{GE}=\pm 15V, T_j=25^\circ C$



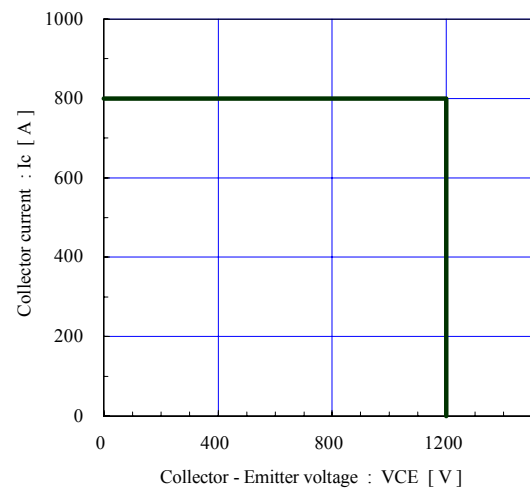
Switching loss vs. Collector current (typ.)  
 $V_{cc}=600V, V_{GE}=\pm 15V, R_g=1.5\Omega$



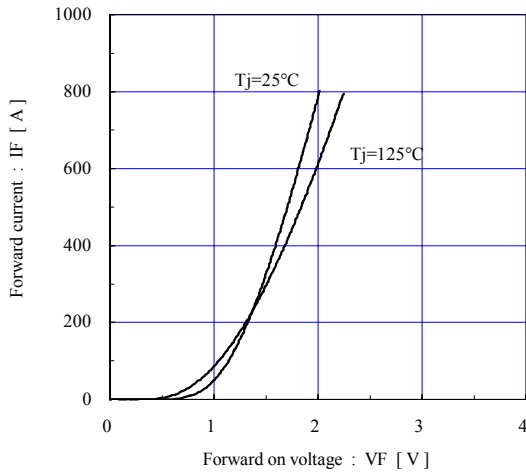
Switching loss vs. Gate resistance (typ.)  
 $V_{cc}=600V, I_c=400A, V_{GE}=\pm 15V, T_j=125^\circ C$



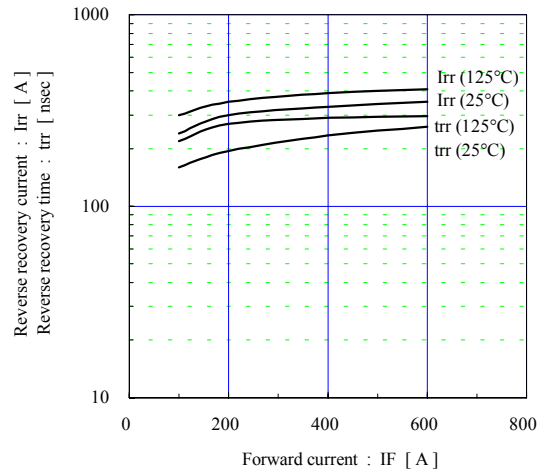
Reverse bias safe operating area (max.)  
 $+V_{GE}=15V, -V_{GE} \leq 15V, R_g \geq 1.5\Omega, T_j \leq 125^\circ C$



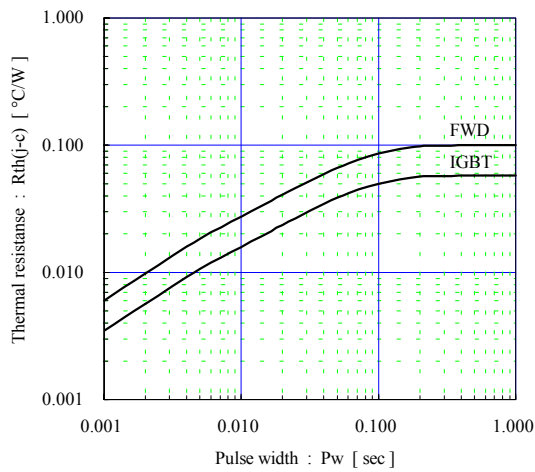
Forward current vs. Forward on voltage (typ.)  
chip



Reverse recovery characteristics (typ.)  
 $V_{cc}=600\text{V}$ ,  $V_{GE}=\pm 15\text{V}$ ,  $R_g=1.5\Omega$



Transient thermal resistance (max.)



■ Outline Drawings, mm

M127

